

Search Notes

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10/527,155

Examiner

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Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

1756

SEARCHED

Class	Subclass	Date	Examiner
430	108.6	6/19/2007	MC
	108.1		
	137.2		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	6/19/2007	MC